

IGBT3 Chip Medium Power

Features:

- 650V Trench & Field Stop technology
- high short circuit capability, self limiting short circuit current
- positive temperature coefficient
- easy paralleling
- Qualified according to JEDEC for target applications

Recommended for:

• power modules

Applications:

drives



Chip Type	V _{CE}	<i>I</i> _{Cn}	Die Size	Package
IGC28T65T8M	650V	50A	6.57 x 4.2 mm ²	sawn on foil

Mechanical Parameters

Die size		6.57 x 4.2		
Emitter pad size (incl. gate pad)		See chip drawing	2	
Gate pad size		0.817 x 1.52	mm ²	
Area total		27.6		
Thickness		80	μm	
Wafer size		200	mm	
Max.possible chips pe	er wafer	974		
Passivation frontside		Photoimide		
Pad metal		3200 nm AlSiCu		
Backside metal		Ni Ag –system		
Die bond		Electrically conductive epoxy glue and soft solder		
Wire bond		Al, <500μm		
Reject ink dot size		Ø 0.65mm; max 1.2mm		
Storage environment	for original and sealed MBB bags	Ambient atmosphere air, Temperature 17°C – 25°C < 6 month		
Storage environment	for open MBB bags	Acc. to IEC62258-3: Atmosphere >99% Nitrogen or inert gas, Humidity <25%RH, Temperature 17°C – 25°C, < 6 month		



Maximum Ratings

Parameter	Symbol	Value	Unit
Collector-Emitter voltage, T_{vj} =25 °C	V _{CE}	650	V
DC collector current, limited by $T_{\rm vj\;max}$	Ic	1)	А
Pulsed collector current, $t_{\rm p}$ limited by $T_{\rm vjmax}^{\ \ 2}$	$I_{c,puls}$	150	А
Gate emitter voltage	$V_{\rm GE}$	±20	V
Operating junction temperature	T _{vj}	-40 +175	°C
Short circuit data $^{2)3)}$ $V_{GE} = 15V$, $V_{CC} = 360V$, $T_{Vj} = 150$ °C	t _{SC}	10	μs

¹⁾ depending on thermal properties of assembly

Static Characteristics (tested on wafer), T_{vj} =25 °C

Parameter	Symbol	Conditions	Value			Unit
Tarameter	Cymbol	Conditions	min.	typ.	max.	
Collector-Emitter breakdown voltage	V _{(BR)CES}	$V_{\rm GE}$ =0V , $I_{\rm C}$ =4 mA	650			
Collector-Emitter saturation voltage	V _{CEsat}	V _{GE} =15V, I _C =50A	1.08	1.55	1.82	V
Gate-Emitter threshold voltage	$V_{\rm GE(th)}$	$I_{\rm C}$ =800 μ A , $V_{\rm GE}$ = $V_{\rm CE}$	5.1	5.8	6.4	
Zero gate voltage collector current	I _{CES}	V_{CE} =650V , V_{GE} =0V			0.28	μA
Gate-Emitter leakage current	I _{GES}	V_{CE} =0V , V_{GE} =20V			600	nA
Integrated gate resistor	$r_{\rm G}$			none		Ω

Electrical Characteristics (not subject to production test - verified by design / characterization)

Parameter	Symbol	Conditions	Value			Unit
raidilletei		Conditions	min.	typ.	max.	Oilit
Collector-Emitter saturation voltage	V _{CEsat}	V_{GE} =15V, I_{C} =50A, T_{vj} =150 °C		1.75		V
Input capacitance	C _{ies}	$V_{\text{CE}} = 25\text{V},$ $V_{\text{GE}} = 0\text{V}, f = 1\text{MHz}$		3140		pF
Reverse transfer capacitance	C _{res}	$T_{\rm vj}$ =25 °C		93		F .

²⁾ not subject to production test - verified by design/characterization

³⁾ allowed number of short circuits: <1000; time between short circuits: >1s.



Further Electrical Characteristic

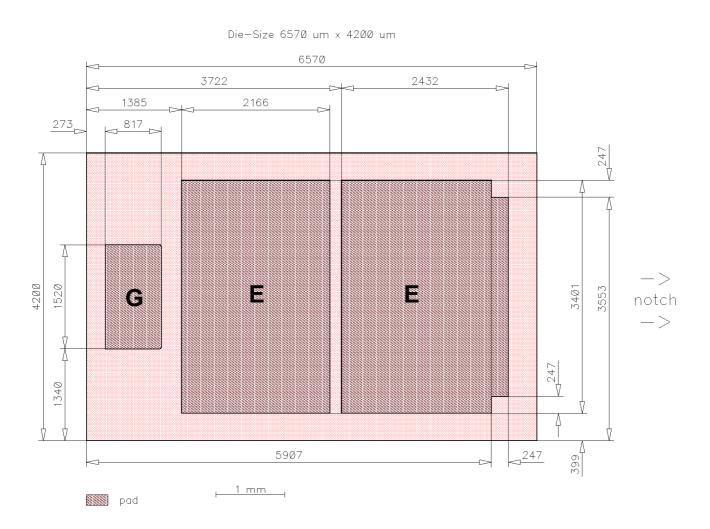
Switching characteristics and thermal properties are depending strongly on module design and mounting technology and can therefore not be specified for a bare die.

This chip data sheet refers to the device data sheet	FS50R07N2E4	Rev 2.0
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Chip Drawing



E = Emitter **G** = Gate



Description
AQL 0,65 for visual inspection according to failure catalogue
Electrostatic Discharge Sensitive Device according to MIL-STD 883

Revision History

Version	Subjects (major changes since last revision)	Date

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